## Application/Control No. Applicant(s)/Patent Under Reexamination 10/531,310 FRENCH ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Shin-Hon Chen 2131 **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY \* US-7,143,438 11-2006 Α Coss et al. 726/11 \* US-6,795,862 09-2004 Keohane et al. В 709/230 С US-US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N 0 Р Q R s Т

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